

NLSX0102

2-Bit 20 Mb/s Dual-Supply Level Translator

The NLSX0102 is a 2-bit configurable dual-supply bidirectional auto sensing translator that does not require a directional control pin. The I/O V_{CC} and I/O V_L ports are designed to track two different power supply rails, V_{CC} and V_L respectively. Both the V_{CC} and V_L supply rails are configurable from 1.5 V to 5.5 V. This allows voltage logic signals on the V_L side to be translated into lower, higher or equal value voltage logic signals on the V_{CC} side, and vice-versa.

The NLSX0102 translator has integrated 10 k Ω pull-up resistors on the I/O lines. The integrated pull-up resistors are used to pull-up the I/O lines to either V_L or V_{CC} . The NLSX0102 is an excellent match for open-drain applications such as the I²C communication bus.

Features

- V_L can be Less than, Greater than or Equal to V_{CC}
- Wide V_{CC} Operating Range: 1.5 V to 5.5 V
Wide V_L Operating Range: 1.5 V to 5.5 V
- High-Speed with 24 Mb/s Guaranteed Data Rate
- Low Bit-to-Bit Skew
- Enable Input and I/O Pins are
Overvoltage Tolerant (OVT) to 5.5 V
- Non-preferential Power-up Sequencing
- Integrated 10 k Ω Pull-up Resistors
- Small Space Saving Package
– 1.9 mm x 0.9 mm x 0.5 mm Flipchip8
- This is a Pb-Free Device

Typical Applications

- I²C, SMBus
- Low Voltage ASIC Level Translation
- Mobile Phones, PDAs, Cameras

Important Information

- ESD Protection for All Pins
– Human Body Model (HBM) > 7000 V



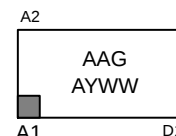
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MARKING DIAGRAM

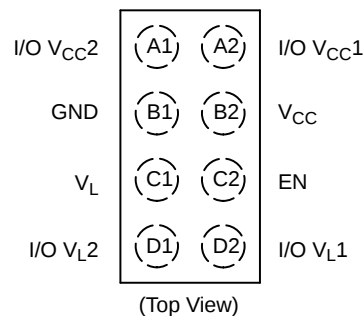


FLIP-CHIP 8
CASE 499BF

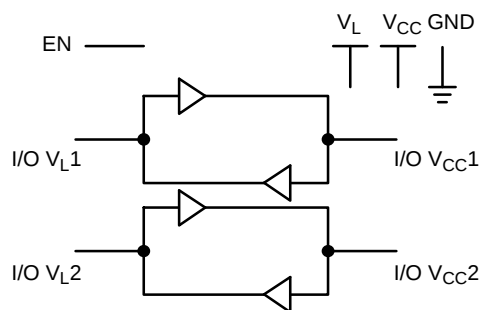


AAG = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week

PIN ASSIGNMENTS



LOGIC DIAGRAM



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 9 of this data sheet.

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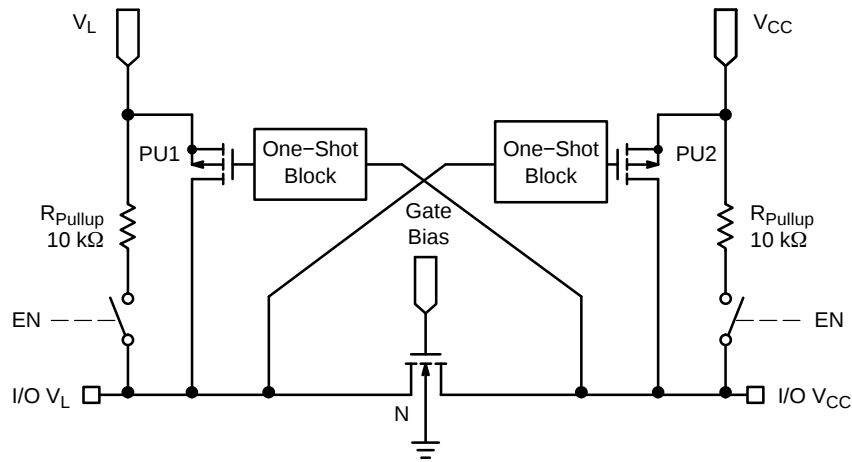


Figure 1. Block Diagram (1 I/O Line)

PIN ASSIGNMENT

Pins	Description
V_{CC}	V_{CC} Supply Voltage
V_L	V_L Supply Voltage
GND	Ground
EN	Output Enable, referenced to V_L
I/O V_{CCn}	I/O Port, referenced to V_{CC}
I/O V_{Ln}	I/O Port, referenced to V_L

FUNCTION TABLE

EN	Operating Mode
L	Hi-Z
H	I/O Buses Connected

MAXIMUM RATINGS

Symbol	Parameter	Value	Condition	Unit
V_{CC}	High-side DC Supply Voltage	-0.5 to +7.0		V
V_L	Low-side DC Supply Voltage	-0.5 to +7.0		V
I/O V_{CC}	V_{CC} -referenced DC Input / Output Voltage	-0.5 to +7.0		V
I/O V_L	V_L -referenced DC Input / Output Voltage	-0.5 to +7.0		V
V_{EN}	Enable Control Pin DC Input Voltage	-0.5 to +7.0		V
I_{I/O_SC}	Short-Circuit Duration (I/O V_L and I/O V_{CC} to GND)	±50	Continuous	mA
I_{I/O_OK}	Input / Output Clamping Current (I/O V_L and I/O V_{CC})	-50	$V_{I/O} < 0$	mA
T_{STG}	Storage Temperature	-65 to +150		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Max	Unit
V _{CC}	High-side Positive DC Supply Voltage	1.5	5.5	V
V _L	Low-side Positive DC Supply Voltage	1.5	5.5	V
V _{EN}	Enable Control Pin Voltage	GND	5.5	V
V _{IO}	I/O Pin Voltage	GND	5.5	V
Δt/ΔV	Input Transition Rise and Fall Rate I/O V _L and I/O V _{CC} Ports, Push-Pull Driving		10	ns/V
	Control Input		10	
T _A	Operating Temperature Range	-40	+85	°C

DC ELECTRICAL CHARACTERISTICS (T_A = -40 to +85 °C, unless otherwise specified)

Symbol	Parameter	Test Conditions (Note 1)	V _L	V _{CC}	-40 °C to +85°C			Unit
					Min	Typ (Notes 1, 2)	Max	
V _{IHC}	I/O V _{CC} Input HIGH Voltage		1.5 to 5.5	1.5 to 5.5	V _{CC} - 0.4		-	V
V _{ILC}	I/O V _{CC} Input LOW Voltage		1.5 to 5.5	1.5 to 5.5			0.15	V
V _{IHL}	I/O V _L Input HIGH Voltage		1.5 to 5.5	1.5 to 5.5	V _L - 0.4		-	V
V _{ILL}	I/O V _L Input LOW Voltage		1.5 to 5.5	1.5 to 5.5			0.15	V
V _{IH}	Control Pin Input HIGH Voltage		1.5 to 5.5	1.5 to 5.5	0.65 * V _L		-	V
V _{IL}	Control Pin Input LOW Voltage		1.5 to 5.5	1.5 to 5.5			0.35 * V _L	V
V _{OHC}	I/O V _{CC} Output HIGH Voltage	I/O V _{CC} source current = -20 μA	1.5 to 5.5	1.5 to 5.5	2/3 * V _{CC}		-	V
V _{OLC}	I/O V _{CC} Output LOW Voltage	I/O V _{CC} sink current = 1 mA	1.5 to 5.5	1.5 to 5.5			0.4	V
V _{OHL}	I/O V _L Output HIGH Voltage	I/O V _L source current = -20 μA	1.5 to 5.5	1.5 to 5.5	2/3 * V _L		-	V
V _{OLL}	I/O V _L Output LOW Voltage	I/O V _L sink current = 1 mA	1.5 to 5.5	1.5 to 5.5			0.4	V
I _{QVL}	V _L Supply Current Supply Current	I/O V _{CC} and I/O V _L unconnected, V _{EN} = V _L	1.5 to 5.5	1.5 to 5.5			2.0	μA
			5.5	0			2.0	
			0	5.5			-1.0	
I _{QVCC}	V _L Supply Current Supply Current	I/O V _{CC} and I/O V _L unconnected, V _{EN} = V _L	1.5 to 5.5	1.5 to 5.5			2.0	μA
			5.5	0			2.0	
			0	5.5			-1.0	
I _{TS-VCC}	V _{CC} Tri-state Output Mode	I/O V _{CC} and I/O V _L unconnected, V _{EN} = GND	1.5 to 5.5	1.5 to 5.5			1.0	μA
I _{TS-VL}	V _L Tri-state Output Mode Supply Current	I/O V _{CC} and I/O V _L unconnected, V _{EN} = GND	1.5 to 5.5	1.5 to 5.5			1.0	μA

- Typical values are for V_{CC} = +3.3 V, V_L = +1.8 V and T_A = +25°C.
- All units are production tested at T_A = +25°C. Limits over the operating temperature range are guaranteed by design.

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DC ELECTRICAL CHARACTERISTICS ($T_A = -40$ to $+85$ °C, unless otherwise specified)

Symbol	Parameter	Test Conditions (Note 1)	V_L	V_{CC}	-40 °C to +85 °C			Unit
					Min	Typ (Notes 1, 2)	Max	
I_I	Enable Pin Input Leakage Current		1.5 to 5.5	1.5 to 5.5			1.0	μA
I_{OZ}	I/O Tri-state Output Mode Leakage Current		1.5 to 5.5	1.5 to 5.5			1.0	μA
R_{PU}	Pull-Up Resistors I/O V_L and V_C					10		k Ω

- Typical values are for $V_{CC} = +3.3$ V, $V_L = +1.8$ V and $T_A = +25$ °C.
- All units are production tested at $T_A = +25$ °C. Limits over the operating temperature range are guaranteed by design.

Timing Characteristics – Rail-to-Rail Driving Configuration

(I/O test circuits of Figures 2, 3 and 7, $C_{LOAD} = 15$ pF, driver output impedance ≤ 50 Ω , $R_{LOAD} = 1$ M Ω , unless otherwise specified)

Symbol	Parameter	Conditions	-40°C to +85°C						Unit
			V _{CC} = 2.3 to 2.7 V		V _{CC} = 3.0 to 3.6 V		V _{CC} = 4.5 to 5.5 V		
			Min	Max	Min	Max	Min	Max	

$V_L = 1.65$ to 1.95 V

t_{RVL}	I/O V_L Rise Time	Figure 8	0.6	9.5	2.3	12.5	0.8	7.6	nS
t_{RVCC}	I/O V_{CC} Rise Time	Figure 8	4.0	10.8	2.7	9.1	2.7	7.6	nS
t_{FVL}	I/O V_L Fall Time	Figure 8	2.0	9.7	1.9	8.1	1.7	13.3	nS
t_{FVCC}	I/O V_{CC} Fall Time	Figure 8	2.9	13.8	2.8	16.2	2.8	16.2	nS
$t_{PHL-VL-VCC}$	Propagation Delay (Driving I/O V_L , V_L to V_{CC})	Figure 2		5.6		7.1		6.8	nS
$t_{PLH-VL-VCC}$				6.5		7.1		7.4	
$t_{PHL-VCC-VL}$	Propagation Delay (Driving I/O V_{CC} , V_{CC} to V_L)	Figure 3		4.8		5.3		2.0	nS
$t_{PLH-VCC-VL}$				4.8		5.0		3.5	
t_{EN}	Enable Time	Figure 7		50		40		35	nS
t_{DIS}	Disable Time	Figure 7		316		225		215	nS
t_{PPSKEW}	Part-to-Part Skew			0.7		0.7		0.7	nS
MDR	Maximum Data Rate		21		22		24		Mbps

$V_L = 2.3$ to 2.7 V

t_{RVL}	I/O V_L Rise Time	Figure 8	2.8	7.7	2.6	8.1	1.8	10.3	nS
t_{RVCC}	I/O V_{CC} Rise Time	Figure 8	3.2	9.2	2.9	8.8	2.4	6.4	nS
t_{FVL}	I/O V_L Fall Time	Figure 8	1.9	8.3	1.9	7.8	1.8	7.4	nS
t_{FVCC}	I/O V_{CC} Fall Time	Figure 8	2.2	8.3	2.4	8.0	2.6	10.0	nS
$t_{PHL-VL-VCC}$	Propagation Delay (Driving I/O V_L , V_L to V_{CC})	Figure 2		3.2		3.7		3.9	nS
$t_{PLH-VL-VCC}$				4.8		5.3		6.0	
$t_{PHL-VCC-VL}$	Propagation Delay (Driving I/O V_{CC} , V_{CC} to V_L)	Figure 3		2.5		1.6		1.0	nS
$t_{PLH-VCC-VL}$				4.5		4.3		3.4	
t_{EN}	Enable Time	Figure 7		50		40		35	nS
t_{DIS}	Disable Time	Figure 7		225		225		215	nS
t_{PPSKEW}	Part-to-Part Skew			0.7		0.7		0.7	nS
MDR	Maximum Data Rate		20		22		24		Mbps

Timing Characteristics – Rail-to-Rail Driving Configuration

(I/O test circuits of Figures 2, 3 and 7, $C_{LOAD} = 15 \text{ pF}$, driver output impedance $\leq 50 \Omega$, $R_{LOAD} = 1 \text{ M}\Omega$, unless otherwise specified)

Symbol	Parameter	Conditions	-40°C to +85°C						Unit
			V _{CC} = 2.3 to 2.7 V		V _{CC} = 3.0 to 3.6 V		V _{CC} = 4.5 to 5.5 V		
			Min	Max	Min	Max	Min	Max	
V _L = 3.0 to 3.6 V									
t _{RVL}	I/O V _L Rise Time	Figure 8			2.3	6.5	1.9	8.0	nS
t _{RVCC}	I/O V _{CC} Rise Time	Figure 8			2.5	6.5	2.1	7.4	nS
t _{FVL}	I/O V _L Fall Time	Figure 8			2.0	7.2	1.9	5.9	nS
t _{FVCC}	I/O V _{CC} Fall Time	Figure 8			2.3	8.0	2.4	9.3	nS
t _{PHL-VL-VCC}	Propagation Delay (Driving I/O V _L , V _L to V _{CC})	Figure 2				2.4		3.1	nS
t _{PLH-VL-VCC}						3.8		3.8	
t _{PHL-VCC-VL}	Propagation Delay (Driving I/O V _{CC} , V _{CC} to V _L)	Figure 3				2.5		2.6	nS
t _{PLH-VCC-VL}						3.6		3.1	
t _{EN}	Enable Time	Figure 7				40		35	nS
t _{DIS}	Disable Time	Figure 7				225		235	nS
t _{PPSKEW}	Part-to-Part Skew					0.7		0.7	nS
MDR	Maximum Data Rate				23		24		Mbps

Timing Characteristics – Open Drain Driving Configuration

(I/O test circuits of Figures 4, 5 and 7, $C_{LOAD} = 15 \text{ pF}$, driver output impedance $\leq 50 \Omega$, $R_{LOAD} = 1 \text{ M}\Omega$, unless otherwise specified)

Symbol	Parameter	Conditions	-40°C to +85°C						Unit
			V _{CC} = 2.3 to 2.7 V		V _{CC} = 3.0 to 3.6 V		V _{CC} = 4.5 to 5.5 V		
			Min	Max	Min	Max	Min	Max	
V _L = 1.65 to 1.95 V									
t _{RVL}	I/O V _L Rise Time	Figure 8	38	340	30	245	22.0	134	nS
t _{RVCC}	I/O V _{CC} Rise Time	Figure 8	34	330	23	218	10.0	120	nS
t _{FVL}	I/O V _L Fall Time	Figure 8	4.4	11.1	4.3	12.0	4.2	14.2	nS
t _{FVCC}	I/O V _{CC} Fall Time	Figure 8	6.9	11	7.5	16.2	7.0	16.2	nS
t _{PHLVL-VCC}	Propagation Delay (Driving I/O V _L , V _L to V _{CC})	Figure 2	2.3	27	2.4	20.0	2.6	23.0	nS
t _{PLHVL-VCC}			45	260	36.0	208	27.0	208	
t _{PHLVCC-VL}	Propagation Delay (Driving I/O V _{CC} , V _{CC} to V _L)	Figure 3	1.9	22	1.1	22.0	1.2	22.0	nS
t _{PLHVCC-VL}			45.0	200	36	150	27.0	112	
t _{EN}	Enable Time	Figure 7		80		70		35	nS
t _{DIS}	Disable Time	Figure 7		250		277		290	nS
t _{PPSKEW}	Part-to-Part Skew			0.7		0.7		0.7	nS
MDR	Maximum Data Rate		2		2		2		Mbps

Timing Characteristics – Open Drain Driving Configuration

(I/O test circuits of Figures 4, 5 and 7, $C_{LOAD} = 15 \text{ pF}$, driver output impedance $\leq 50 \Omega$, $R_{LOAD} = 1 \text{ M}\Omega$, unless otherwise specified)

Symbol	Parameter	Conditions	–40°C to +85°C						Unit
			V _{CC} = 2.3 to 2.7 V		V _{CC} = 3.0 to 3.6 V		V _{CC} = 4.5 to 5.5 V		
			Min	Max	Min	Max	Min	Max	

$V_L = 2.3 \text{ to } 2.7 \text{ V}$

t_{RVL}	I/O V_L Rise Time	Figure 8	34	400	28.0	300	24.0	208	nS
t_{RVCC}	I/O V_{CC} Rise Time	Figure 8	35.0	352	24.0	280	12.0	180	nS
t_{FVL}	I/O V_L Fall Time	Figure 8	4.4	6.9	4.3	6.2	4.2	7.8	nS
t_{FVCC}	I/O V_{CC} Fall Time	Figure 8	4.3	8.8	4.9	9.4	5.4	10.4	nS
$t_{PHLVL-VCC}$	Propagation Delay (Driving I/O V_L , V_L to V_{CC})	Figure 2	1.7	14.0	2.0	14.0	2.1	14.0	nS
$t_{PLHVL-VCC}$			43.0	250	36.0	210	27.0	210	
$t_{PHLVCC-VL}$	Propagation Delay (Driving I/O V_{CC} , V_{CC} to V_L)	Figure 3	1.8	13.0	2.6	13.0	1.2	13.0	nS
$t_{PLHVCC-VL}$			44.0	225	37.0	180	27.0	144	
t_{EN}	Enable Time	Figure 7		50		40		35	nS
t_{DIS}	Disable Time	Figure 7		265		230		215	nS
t_{PPSKEW}	Part-to-Part Skew			0.7		0.7		0.7	nS
MDR	Maximum Data Rate		2		2		2		Mbps

$V_L = 3.0 \text{ to } 3.6 \text{ V}$

t_{RVL}	I/O V_L Rise Time	Figure 8			25.0	400	19.0	278	nS
t_{RVCC}	I/O V_{CC} Rise Time	Figure 8			26.0	375	14.0	247	nS
t_{FVL}	I/O V_L Fall Time	Figure 8			2.8	6.1	2.6	5.7	nS
t_{FVCC}	I/O V_{CC} Fall Time	Figure 8			2.6	7.6	3.1	8.3	nS
$t_{PHLVL-VCC}$	Propagation Delay (Driving I/O V_L , V_L to V_{CC})	Figure 2			1.3	10.0	1.4	8.0	nS
$t_{PLHVL-VCC}$					36.0	255	28.0	243	
$t_{PHLVCC-VL}$	Propagation Delay (Driving I/O V_{CC} , V_{CC} to V_L)	Figure 3			1.0	124	1.0	97.0	nS
$t_{PLHVCC-VL}$					3.0	185	3.0	136	
t_{EN}	Enable Time	Figure 7				40		35	nS
t_{DIS}	Disable Time	Figure 7				250		205	nS
t_{PPSKEW}	Part-to-Part Skew					0.7		0.7	nS
MDR	Maximum Data Rate				2		2		Mbps

TEST SETUPS

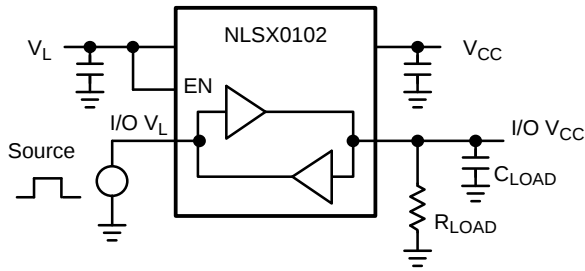


Figure 2. Rail-to-Rail Driving I/O V_L

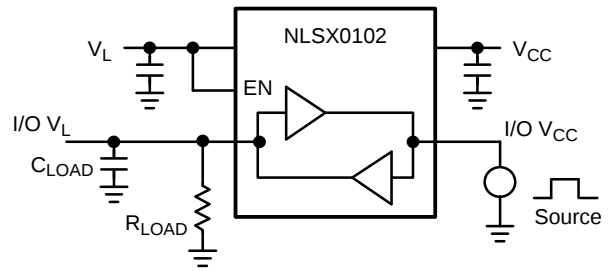


Figure 3. Rail-to-Rail Driving I/O V_{CC}

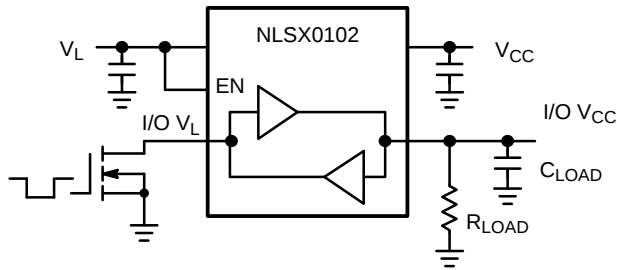


Figure 4. Open-Drain Driving I/O V_L

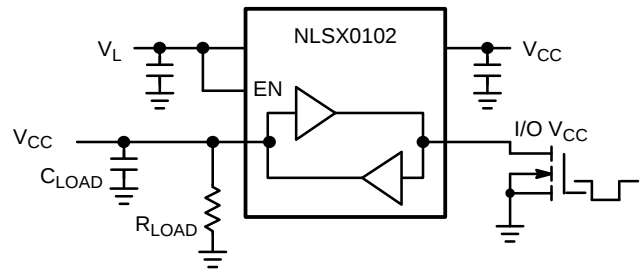


Figure 5. Open-Drain Driving I/O V_{CC}

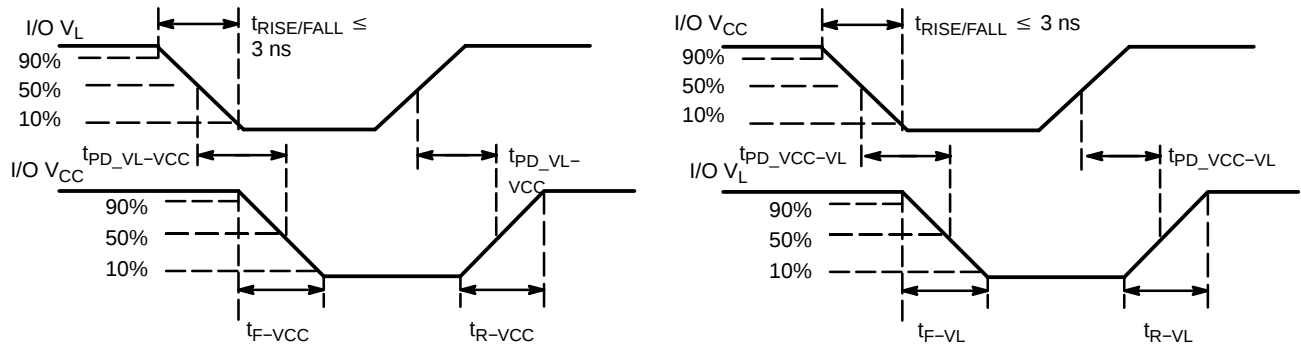
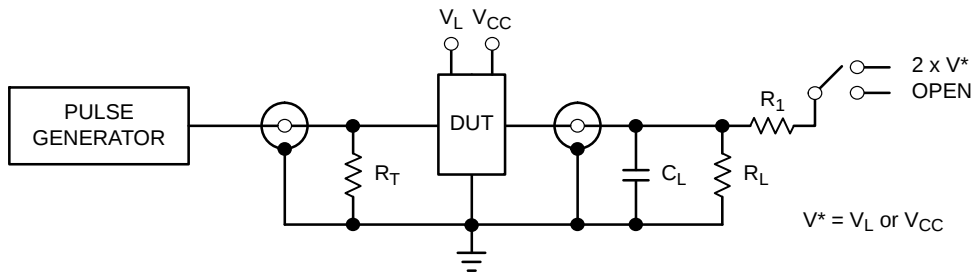


Figure 6. Definition of Timing Specification Parameters

NLSX0102



Test	Switch
t_{PZH} , t_{PHZ}	Open
t_{PZL} , t_{PLZ}	$2 \times V^*$

$C_L = 15 \text{ pF}$ or equivalent (Includes jig and probe capacitance)
 $R_L = R_1 = 50 \text{ k}\Omega$ or equivalent
 $R_T = Z_{OUT}$ of pulse generator (typically 50Ω)
 $V^* = V_L$ or V_{CC} for I/O_VL or I/O_VCC measurements, respectively.

Figure 7. Test Circuit for Enable/Disable Time Measurement

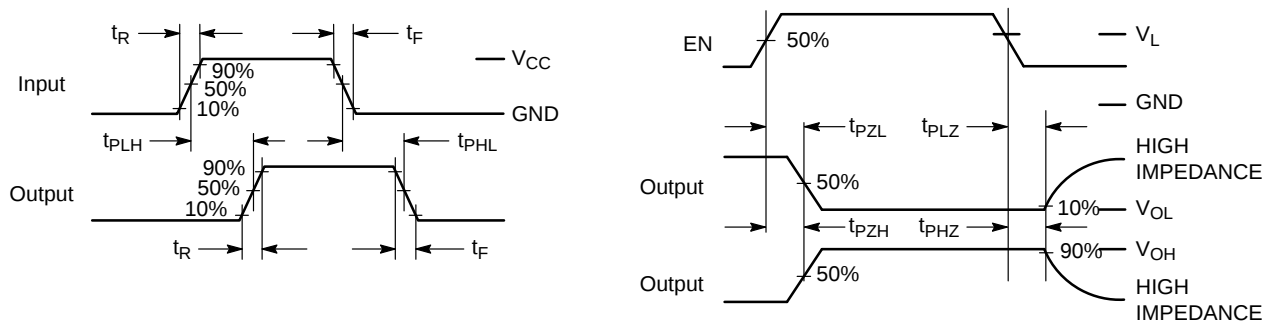


Figure 8. Timing Definitions for Propagation Delays and Enable/Disable Measurement

APPLICATIONS INFORMATION

Level Translator Architecture

The NLSX0102 auto sense translator provides bi-directional voltage level shifting to transfer data in multiple supply voltage systems. This device has two supply voltages, V_L and V_{CC} , which set the logic levels on the input and output sides of the translator. When used to transfer data from the V_L to the V_{CC} ports, input signals referenced to the V_L supply are translated to output signals with a logic level matched to V_{CC} . In a similar manner, the V_{CC} to V_L translation shifts input signals with a logic level compatible to V_{CC} to an output signal matched to V_L .

The NLSX0102 consists of two bi-directional channels that independently determine the direction of the data flow without requiring a directional pin. The one-shot circuits are used to detect the rising or falling input signals. In addition, the one shots decrease the rise and fall time of the output signal for high-to-low and low-to-high transitions. Each input/output channel has an internal 10 k Ω pull-up. The magnitude of the pull-up resistors can be reduced by connecting external resistors in parallel to the internal 10 k Ω resistors.

Input Driver Requirements

The rise (t_R) and fall (t_F) timing parameters of the open drain outputs depend on the magnitude of the pull-up resistors. In addition, the propagation times (t_{PD}), skew (t_{PSKEW}) and maximum data rate depend on the impedance

of the device that is connected to the translator. The timing parameters listed in the data sheet assume that the output impedance of the drivers connected to the translator is less than 50 k Ω .

Enable Input (EN)

The NLSX0102 has an Enable pin (EN) that provides tri-state operation at the I/O pins. Driving the Enable pin to a low logic level minimizes the power consumption of the device and drives the I/O V_{CC} and I/O V_L pins to a high impedance state. Normal translation operation occurs when the EN pin is equal to a logic high signal. The EN pin is referenced to the V_L supply and has Overvoltage Tolerant (OVT) protection.

Power Supply Guidelines

During normal operation, supply voltage V_L can be greater than, less than or equal to V_{CC} . The sequencing of the power supplies will not damage the device during the power up operation. For optimal performance, 0.01 μ F to 0.1 μ F decoupling capacitors should be used on the V_L and V_{CC} power supply pins. Ceramic capacitors are a good design choice to filter and bypass any noise signals on the voltage lines to the ground plane of the PCB. The noise immunity will be maximized by placing the capacitors as close as possible to the supply and ground pins, along with minimizing the PCB connection traces.

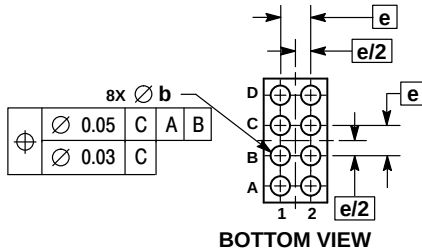
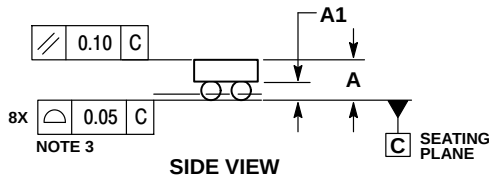
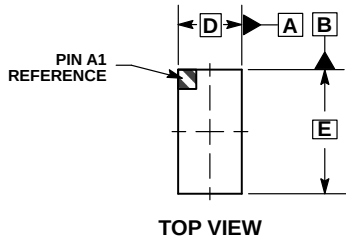
ORDERING INFORMATION

Device	Package	Shipping [†]
NLSX0102FCT1G	Flip-Chip 8 (Pb-Free)	3000 / Tape & Reel
NLSX0102FCT2G	Flip-Chip 8 (Pb-Free)	3000 / Tape & Reel (4mm Pitch Carrier Tape)
NLSX0102FC2T2G	Flip-Chip 8 (Pb-Free)	3000 / Tape & Reel (2mm Pitch Carrier Tape)

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

8 PIN FLIP-CHIP, 0.9x1.9, 0.5P
CASE 499BF
ISSUE O

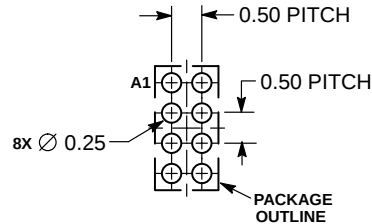


NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
2. CONTROLLING DIMENSION: MILLIMETERS.
3. COPLANARITY APPLIES TO SPHERICAL CROWNS OF SOLDER BALLS.

DIM	MILLIMETERS	
	MIN	MAX
A	0.44	0.50
A1	0.15	0.19
b	0.21	0.25
D	0.90 BSC	
E	1.90 BSC	
e	0.50 BSC	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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